

TEST REPORT: IRM-01-5

1W Single Output Encapsulated Type

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Component Stress Test

■ SAFETY & E.M.C. TEST

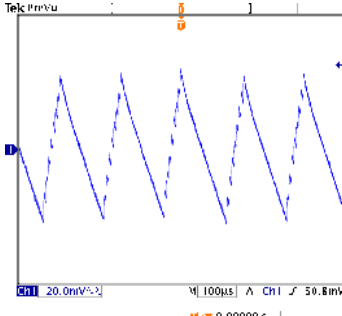
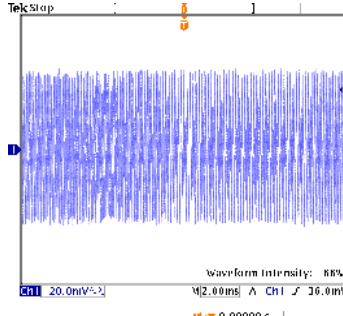
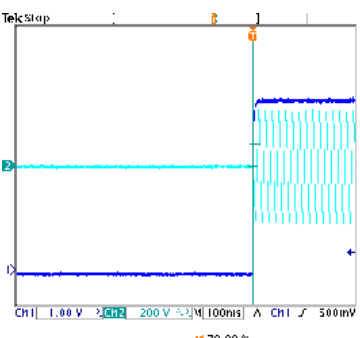
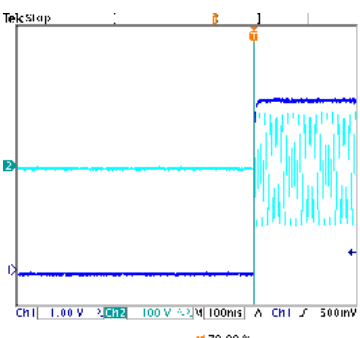
Safety Test

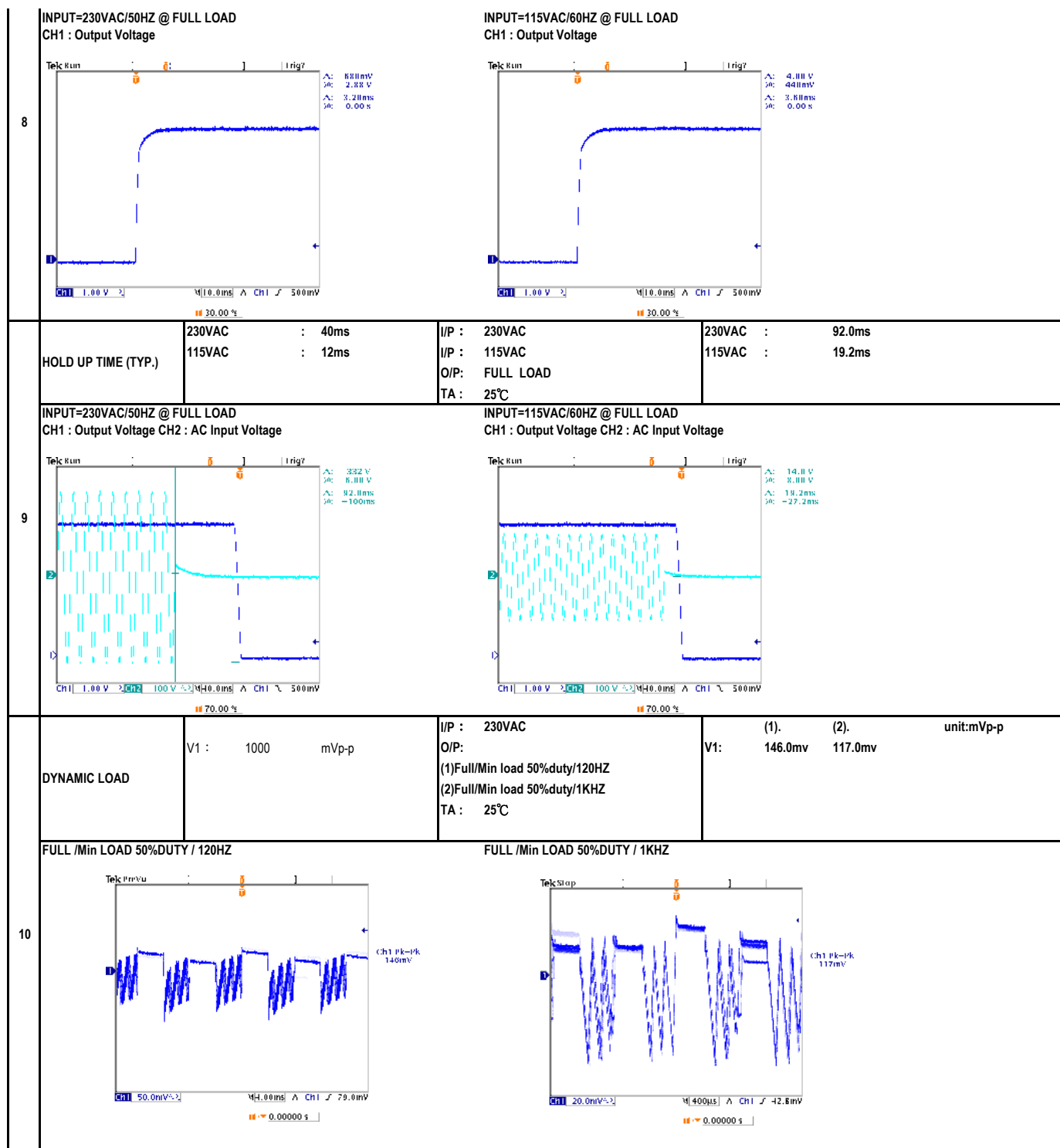
E.M.C. Test

■ RELIABILITY TEST

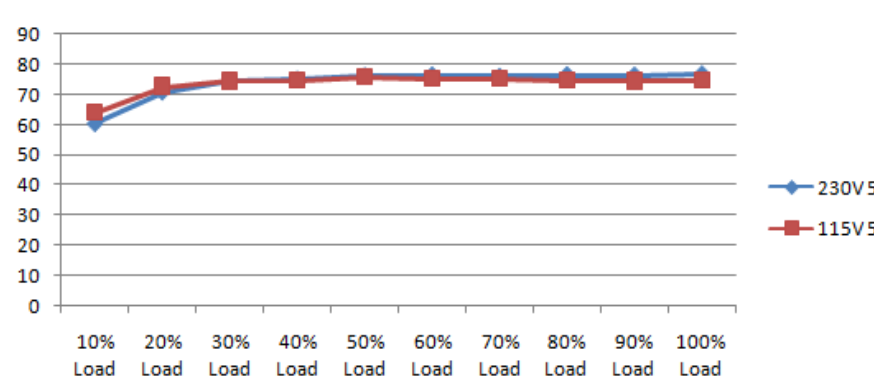
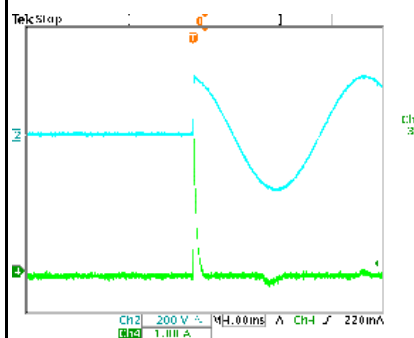
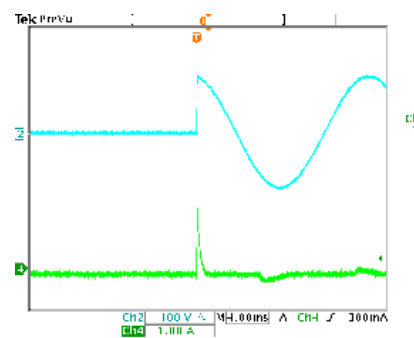
ENVIRONMENT TEST

DESIGN VERIFY TEST OUTPUT FUNCTION

CUT OFF FUNCTION					
NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	
1	OUTPUT VOLTAGE RANGE	CH1: 4.950V ~ 5.050V	I/P : 230VAC O/P: MIN LOAD TA : 25°C	CH1: 4.99V	
2	OUTPUT VOLTAGE TOLERANCE (Max)	V1 : 2.5% ~ -2.5%	I/P : 100VAC / 305VAC O/P: FULL / MINLOAD TA= 25°C	V1: 0.00% ~ -0.20%	
3	LINE REGULATION (MAX.)	V1 : 0.5% ~ -0.5%	I/P : 100VAC / 305VAC O/P: FULL LOAD TA : 25°C	V1: 0.00% ~ 0.00%	
4	LOAD REGULATION (MAX.)	V1 : 0.5% ~ -0.5%	I/P : 230VAC O/P: MIN LOAD ~ FULL LOAD TA : 25°C	V1: 0.20% ~ 0.00%	
5	OVER/UNDERSHOOT TEST	< ±10%	I/P : 230VAC O/P: FULL LOAD TA : 25°C	TEST< 2.42 %	
6	RIPPLE & NOISE(Max)	V1 : 150 mVp-p	I/P : 230VAC O/P: FULL LOAD TA : 25°C	V1 : 94.40 mVp-p	
		high frequency :		low frequency :	
					
7	SET UP TIME (MAX.)	230VAC : 600ms 115VAC : 600ms	I/P : 230VAC I/P : 115VAC	230VAC : 6ms 115VAC : 6ms	
		INPUT=230VAC/50HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage		INPUT=115VAC/60HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage	
					
	RISE TIME (MAX.)	230VAC : 30ms 115VAC : 30ms	I/P : 230VAC I/P : 115VAC O/P: FULL LOAD TA : 25°C	230VAC : 3.2ms 115VAC : 3.6ms	



INPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	INPUT VOLTAGE RANGE	85VAC ~ 305VAC 120VDC ~ 430VDC	I/P : TESTING O/P : FULL LOAD Ta : 25°C I/P : LOW-LINE = 97VAC HIGH-LINE = 315VAC O/P : FULL/MIN LOAD ON:30 Sec ; OFF:30 Sec 10MIN (POWER ON/OFF NO DAMAGE)	51.0VAC ~ 305VAC 84VDC ~ 430VDC TEST : OK
2	INPUT FREQUENCY RANGE	47HZ ~ 63HZ NO DAMAGE	I/P : 100VAC ~ 305VAC O/P : FULL~MIN LOAD Ta : 25°C	TEST : OK
3	INPUT CURRENT (TYP.)	0.018A / 230VAC 0.025A / 115VAC 0.016A / 277VAC	I/P : 230VAC I/P : 115VAC O/P : FULL LOAD TA : 25°C	I= 0.01099A / 230VAC I= 0.01799A / 115VAC I= 0.01000A / 277VAC
4	LEAKAGE CURRENT	< 0.25mA	I/P : 277VAC O/P : MIN LOAD TA : 25°C	L-O/P: 0.011 mA N-O/P: 0.0111 mA
5	NO LOAD POWER CONSUMPTION	< 0.075W	I/P : 230VAC O/P : MIN LOAD TA : 25°C	< 0.0354 W
6	EFFICIENCY (TYP.)	70.0%	I/P : 230VAC O/P : FULL LOAD TA : 25°C	78.164 %
				
7	INRUSH CURRENT (TYP.)	10A / 230VAC 5A / 115VAC twidth= 0 us measured at 50% Ipeak COLD START	I/P : 230VAC I/P : 115VAC O/P : FULL LOAD TA : 25°C	I= 3.84A / 230VAC I= 1.88A / 115VAC
INPUT=230VAC/50HZ @ FULL LOAD CH2 : Input current (1V=1A) CH4 : AC Input Voltage  INPUT=115VAC/50HZ @ FULL LOAD CH2 : Input current (1V=1A) CH4 : AC Input Voltage 				

PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OVER LOAD PROTECTION	> 110%	I/P: 305VAC I/P: 230VAC I/P: 100VAC O/P: TESTING Ta: 25°C	754% 305VAC 624% 230VAC 464% 100VAC Hiccup Mode
2	OVER VOLTAGE PROTECTION	5.20V ~ 6.80V	I/P: 305VAC I/P: 230VAC I/P: 85VAC O/P: MIN LOAD Ta: 25°C	6.10V 305VAC 6.10V 230VAC 6.10V 85VAC Shut off o/p voltage, clamping by zener diode
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P: 305VAC I/P: 85VAC O/P: FULL LOAD Ta: 25°C	NO DAMAGE Hiccup Mode

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	PWM Power Transistor	Q1 Rated : 700V 0.4A	I/P : 315VAC VDS : O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	VIN: 315VAC VDS: (1). 632.00V (2). 666.00V (3). 632.00V
2	Input Capacitor	C6 Rated : 5uf 450V	I/P : 315VAC O/P : (1)Full Load Turn on /Off (2)Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1). 444.00V (2). 448.00V (3). 448.00V
3	Control IC	U1 Rated : 9.00V (max) -0.3V (min)	I/P : 315VAC O/P : (1)Full Load (2)Output Short (3)O.L.P (4)Low Line No Load Vo(min) Ta : 25°C	U1 (1). 6.44V (2). 6.36V (3). 6.32V (4). 6.44V
5	O/P Diode	D100 Rated : 45V 5.0A	I/P : 315VAC O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	(1). 31.80V (2). 36.80V (3). 31.40V
6	Clamp Diode	D1 Rated : 1000V 1.0A	I/P : 315VAC O/P : (1)Full load continue Ta : 25°C	(1). 592.00V

SAFETY & E.M.C. TEST

SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	WITHSTAND VOLTAGE	I/P-O/P : 3.000KVAC /min	I/P-O/P: 3.300KVAC /min Ta : 25°C	I/P-O/P: 0.49mA NO DAMAGE
2	ISOLATION RESISTANCE	I/P-O/P : 500VDC>100MΩ	I/P-O/P: 500VDC Ta : 25°C/70%RH	I/P-O/P: 9999MΩ NO DAMAGE

E.M.C. TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	HARMONIC	EN61000-3-2 CLASS A	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	PASS
2	CONDUCTION	EN55022 CLASS B	I/P : 230VAC /50HZ O/P : FULL LOAD / 50% LOAD Ta : 25°C	PASS Test by certified Lab
3	RADIATION	EN55022 CLASS B	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	PASS Test by certified Lab
4	E.S.D	EN61000-4-2 INDUSTRY AIR: 8KV / Contact: 4KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A
5	E.F.T	EN61000-4-4 INDUSTRY INPUT: 2KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A
6	SURGE	IEC61000-4-5 INDUSTRY L-N: 1KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A

RELIABILITY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	TEMPERATURE RISE TEST	MODEL : IRM-01-3.3 1. ROOM AMBIENT BURN-IN : 1.0hrs IP: 230VAC O/P: 100% LOAD TA= 15.9°C 2. HIGH AMBIENT BURN-IN : 1.0hrs IP: 230VAC O/P: 100% LOAD TA= 75.0°C	NO. Position ROOM AMBIENT 15.9°C HIGH AMBIENT Ta: 75.0°C 1 C101 27.1°C 86.3°C 2 T1 28.9°C 88.5°C 3 C6 24.9°C 84.5°C 4 BD1 26.1°C 85.8°C 5 R2 24.6°C 84.1°C 6 L1 25.6°C 85.0°C 7 U1 28.2°C 88.0°C 8 D100 31.5°C 90.6°C 9 D1 27.9°C 87.7°C 10 CASE 26.4°C 85.9°C	
2	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 230VAC O/P : 550.00% LOAD Ta : 25°C	TEST : OK
3	LOW TEMPERATURE TURN ON TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 305VAC / 100VAC O/P : FULL LOAD Ta : -30.0°C	TEST : OK
4	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 75°C NO DAMAGE	I/P : 315VAC O/P : FULL LOAD Ta : 75°C HUMIDITY= 95.0% RH	TEST : OK
5	TEMPERATURE COEFFICIENT	±0.03% /(0°C~75°C)	I/P : 230VAC O/P : FULL LOAD	±0.0000% /(0°C~75°C)
6	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -40°C ~ +100°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 5 CYCLE 5. Input/Output condition : STATIC		TEST : OK
7	THERMAL SHOCK TEST	1. Thermal shock Temperature : -35°C ~ +80°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : 230VAC Full Load AC ON/OFF test turn on 58sec : turn off 2sec		TEST : OK



8	VIBRATION TEST	1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10~500Hz (4) Acceleration : 5G (5) Test Time : 60 min in each axis (X.Y.Z) (6) Ta : 25°C	TEST : OK
9	CAPACITOR LIFE CYCLE	:SUPPOSE C101 IS THE MOST CRITICAL COMPONENT (1) I/P : 230VAC O/P : FULL LOAD Ta= 25.0°C LIFE TIME (2) I/P : 230VAC O/P : FULL LOAD Ta= 75.0°C LIFE TIME (3) I/P : 230VAC O/P : 75% LOAD Ta= 75.0°C LIFE TIME (4) I/P : 230VAC O/P : 50% LOAD Ta= 75.0°C LIFE TIME	(1). 158118 HRS (2). 44588.4 HRS (3). 56064 HRS (4). 70605.6 HRS
10	MTBF	Conducted by Parts Stress Analysis Prediction 1960K hrs min. MIL-HDBK-217F (25°C)	
11	DMTBF /Accelerated Life test	Demonstration Mean Time Between Failure (Expected Life): Above 30000HRS @ TA 75°C	

TEST RESULT	TESTER	REVIEW	APPROVAL
PASS	FRANK	GESG	WANGDZ

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